EDMPUTER EDNVERSIONS EDRPORATION WWW.COMPUTERCONVERSIONS.COM PHONE: (631)261-3300 FAX. 261-3308 6 DUNTON CT., E. NORTHPORT, NEW YORK, USA 11731

FEATURES

- Up to 8 Isolated Input Channels/Card
- Synchro, Resolver and LVDT I/O
- Independent Tracking Converters
- Mix-Match up to 8 Converters/Card
- 100% Transformer Isolated I/O Units
- Loop-Back Testing Cards Available
- Self-Test Models w/Continuous Fit.
- Proven "Industry Std. Converters"
- Reliable Register Based "LSI" Logic
- Quadrature Incremental Encoder Outputs for Motion Controllers' Input
- On-Board Reference Supplies
- Absolute Multi-Speed/Multiturn I/O

Overview

The "VB Series" products line contains VME compatible synchro/resolver converters and absolute encoder systems. These particular cards are ideal for any rotary motion and related process, control, or simulator type application with any VME compatible system.

The **VB Series** provide up to **eight channels** of resolver or synchro conversion on a single-width, standard 6U height VME card.

The **VBE Series** Resolver/Encoder systems feature up to 6 axis of shaft angle position encoding with a choice of single or multiturn resolvers used as the sensor inputs.

CCC's full line of "Industry Standard" Synchro/Resolver converters, and Absolute Encoder products, are used to populate standard multifunction VME decoder cards. Differing converters may be mixed to minimize real estate for a particular application.

Both *industrial and military grade* (extended) temperature range versions are available, with forced air or conduction cooled models having thermal layers and expansion wedge style card locks. Accuracy applies over the operating temperature range, and 883 level B/38510 parts/processing is available on all units.

Transformer isolation is offered for all inputs and outputs, eliminating concerns for ground loops, differing potentials and high voltage field transients affecting the card itself and the VME Bus backplane. All input cards feature Built-In Fault Detect, Self-Test command angle is optioned, and models with True Wrap Around Test (VBT's).

Maximum versatility has been employed on all "VB" products to assure universal compatibility in addressing, timing, system, and microcomputer independence.

All VB Series converter cards are configured as **A24:D16 DTB Slaves**. They will respond to address modifier codes "3D" or 39 for standard addressing, and "2D" or "29" when selected for short I/O type addressing.

The VME interface is a very straightforward register based design; simply address the channel and read or write the data.

Status registers are used to provide card configuration data, and on a per channel basis, to provide channel config. and fault status.

The high speed register based interface allows these cards to operate reliably in any software environment, with uninhibited *Real-Time* performance.

Buffered latches are provided on all data lines to assure stable read and write cycles as commanded by the host. Address and control lines feature single point terminations to minimize any loading of the backplane. All signal output converters are provided with *inherent read-back* ability.

VB SERIES SYNCHRO-RESOLVER-ENCODER VME CARD OVERVIEW VBR,VBW,VBE,VBB,VBT,VBDT Series Introduction



BOSCONVERTER SELECTIONS.
O Synchro/Resolver to Digital
O Absolute Encoder/Resolver Systems
O Digital to Synchro/Resolver
O Multispeed & Multiturn Converters
O DC Sine/Cos. Vector Generators
O Multifunction Dynamic Rotators
○ 2 & 3 Wire LVDT/RVDT to Digital
O Digital to LVDT/RVDT Simulators
O Active CDX Control Differentials
O Active CT Control Transformers
O Active Incremental Outputs & Ref.
○ Isolated D-A, s and Tracking A-D's
 O Built in Fault Detect, Forced-Test and True Isolated Wrap-Around Test
O Programmable Reference Supplies



No external Power Supplies are required, every card is available as powered with standard + 12 an +5VVME Bus standard supplies.

Power source jumpers are provided to select the ± 12 VDC power input source, via the external connector port, or the VME BUS P1 backplane.

CCC's VB cards include two 25 pin polarized "D" style subminiature connectors on the *front panel* for all external I/O, and/or the P2 connector I/O is available as an option.

The availability of Self-Test Command Angle options (-WS), and True Wrap-Around loop back-test boards (VBT and VBDT Series), allow the user to configure automatic self test and simulation type programs at any level.

Because the VB Series uses proven, and reliable "whole" converter products, coupled with the use of leading edge LSI interface technology, the VB Series cards offer quick availability, competitive pricing and the best density verses performance ratio available in the marketplace.

VBR,VBW,VBE,&VBB SERIES ADRESS MAP															
HEX	Ad	ldres	ss Bi	its	Converter	Chan									
Selec	A4	A3	A2	A1	Function	Chan									
00h	0	0	0	0		0									
02h	0	0	0	1	Write Cherr	1									
04h	0	0	1	0	While Chan.	2									
06h	0	0	1	1		3									
08h	0	1	0	0		0									
0Ah	0	1	0	1	Read-Back	1									
0Ch	0	1	1	0	Chan.	2									
0Eh	0	1	1	1		3									
10h	1	0	0	0		0									
12h	1	0	0	1	*Read Status	1									
14h	1	0	1	0	Chan.	2									
16h	1	0	1	1		3									
*-W	S Ur	nits V	Write	Cor	nmand Self-Test	*-WS Units Write Command Self-Test Angle									



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VBR SERIES SYNCHRO & RESOLVER TO DIGITAL VME BUS INPUT CARDS

AVAILABLE FEATURES Resolution 10 to 18 Bits Transformer Isolated Inputs Ratiometric Tracking Converters Tracking Rates of 600 RPS DC Velocity & Incremental Outputs Insensitive to Frequency & Amplitude Variations IND. TEMP/Mil Spec./Hi Rel Options 1 to 4 Channels Per Card, VBD for 8 Proven "Industry Standard Converters" On-Board Reference Supplies



Description

The VB S/R series are 1-4 channel continuously tracking synchro or resolver to VME card converters, employing a type 2 ratiometric conversion loop for high speed/ high performance applications. They will accept any of 4 individual, or paired 3-wire *synchro* or 4-wire *resolver* inputs over a frequency range of 50 to 10KHZ., and convert them simultaneously into 10-16 bit words of natural binary data. Data is addressable in a single word 16 bit format over the VME backplane.

Data made available to the bus is continuously updated (tracking) without interruption; output *data is stable, accurate, and always fresh* up to the maximum tracking rate of the converter. When address and control variables are set, all data bits are latched simultaneously into separate buffered registers to prevent false reads.

Isolation

No external transformers, modules or signal conditioning is required. The synchro/resolver converters used feature internal solid-state or transformer Scott T's that accept *direct field voltage inputs*.

Transformer isolated units are completely isolated from each other and the backplane for all the reference and signal lines. This completely **isolates the card and effectively the whole computer from all field wiring**, eliminating concerns over troublesome **ground loops**, differing potentials, ground interjected spikes, **or ghostly field noise** that so frequently takes down entire systems.

Multispeed/Multiturn

The VBR Hardware *inherently supports* four channels of discreet S-D/R-D conversion, two channels of *multispeed/multiturn* S-D/R-D conversion, or a combination of both.

The Firmware supports simultaneous two channel store-to-read configuration required to properly interrogate multispeed/multiturn resolvers and synchro's. Furthermore, precombined converters can be supplied as an option.

Bus Powered

Power required is ± 15 and +5VDC as standard; ± 12 VDC is optioned, and the source for the ± 12 or ± 15 V input is strap selectable for **power sourcing via the backplane or externally** powered via the I/O connector.

Built-In-Test/Self-Test

All units include a continuous built-in-test, converter and I/O fault detect, and -WS option units include a command to 30 degree test angle for self-test. Options currently available include DC velocity output, a *built-in-test* output representing the tracking mode, internal reference supplies, quadrature *incremental pulse train outputs*, mil-grade *extended temperatures*, and 883 level B processing.

APPLICATIONS

- O Antenna Monitoring
- O Closed Loop Servo Controls
- O Avionic & Naval Systems
- O Conveyor Controls
- O Ship Speed & Navigation
- O Machine Control Systems
- O Shaft Angle Encoding
- O Engine Test Stands
- O Material Handling Systems

Specifications									
		10 Bits	12 Bits	14 Bits	16 Bits	18 Bits			
Accuracy:	Standard;	+/-30'	+/-4' +	1 LSB	+/-4'	+/-1'			
	-GA Models		+	/-4.5' + 1 LS	B				
	-HA Models	+/-21'		+/-2.7 -	⊦ 1 LSB	+/-10 sec.			
Tracking Rate:	60Hz.	12.5	10	2.5	0.625	0.25			
(RPS)	400Hz.	40	40	10	2.5	1			
	2.5KHz.	100	80	30	5	1.2			
-HS Models	2.5KHz.	200	200	50	10				
Acceleration:	60Hz.	770	295	20					
(for a 1 LSB lag)	400Hz.	12600	4500	610	124				
	2.5KHZ.	2500	9000	1620					
-HS Models		1400	350	70					
	400Hz.	22000	5500	1100					
	2.5Hz.	160K	40000	8100					
Step Response:	60Hz.	200ms.	360ms.	800ms.	1200ms.				
	2.5KHz.	95ms.	95ms.	150ms.	600ms.	2000ms.			
Frequency Range:	60Hz. units 47-100Hz. 400Hz. units 360-2000Hz.								
	2.5KHz. units	2000-4800H	lz	Higher Fred	quencies Ava	ailable			
Reference Inputs:	26VRMS into 90K ohms								
			115VRMS	6 into 360K o	ohms				
Signal Inputs:		11.8VRMS	L-L into 26k	Cohms Minir	num L-L Bal	anced			
		26VRMS I	L-L into 26K	ohms Minim	ium L-L Bala	inced			
		90VRMS	L-L to 200K	ohms Minim	um L-L Bala	nced			
Breakdown (volts):		500 VDC	Minimum to	Ground on	Fransformer	Units			
Common Mode:		80	Db. Minimu	m on Solid S	state Units				
Power Supplies:	+5VDC@0.8 A	Amp., +125m	a./channel						
	+12VDC@35m	na./chn, -12\	/DC@45ma	/chn (-12 un	its), -WR un	its add 450 ma. ea.+			
	or, +15VDC@3	25ma./chn, -	15VDC@35	ma./chn, -W	R units add	400ma. ea.			
Temperature:	00	to 55C on c	card level un	its, 0C to +7	0C on conv.	, (-1 units)			
	-40C	; to +75C on	card level, u	inits -40C to	+85C on co	nv. (-3 units)			
(operating)	-55C	to +85C on	card level u	nits, 55C ti +	-105C on co	nv. (-2 units)			
Storage			-550	C to +125C					
Notes: 1.) ALL UNITS 2.) Accuracy a 3.) Different in 4.) For units wi	AVAILABLE WIT pplies over the op put voltages and t ith solid state input	H SOLID STA perating temp. frequencies av ut line may be	TE OR TRAN range, +/-10% /ailable, Fixed grounded. Co	SFORMER IS 6 amplitude & and Program	SOLATED SIG frequency, +/ mable Refere upto max. L-L	NAL & REF INPUTS -5% power nce Supplies			

- and 80 Db. common mode std.
- 5.) Higher accuracy, faster settling times and higher rates available
- 6.) 883 Level B/38510 WA High Rel. available on select units

*7.) 16 Bit units with accuracy of +/-20arc. seconds \$ 20 Bit units available O Copyright 1997-2004 CCC



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VBT & VBDT SERIES VME BUS W/BUILT-IN TEST BUS SYNCHRO/RESOLVER CONVERTERS

FEATURES

- O True Wrap-Around Converter Testing
- O On and Off Card Loop-Back Testing
- O Expandable Off-Card Test Bus
- Isolation Through-Out Implementation
- $\rm O\,$ Real-Time and Off-Line Testing
- $\rm O~$ I/O Can Be Disconnected/Module
- O Verification of On Versus Off Card Faults
- O Intelligent Test Bus Routing Logic
- O Dual Off-Card Buses Per Card
- O Elaborate Backplanes Not Required
- O Up to 6 Isolated Channels/Card

Overview

The VBT and VBDT Cards are full function 3 and 6 channel VME Bus cards with added support logic for CCC's "*Advanced Random Signal Test Bus*TM" (*ARS T-Bus*TM).

The "ARS T-BusTM uses a interlocked relay switching matrix, that allows all the signal lines from one converter module to be selectively routed to any other compatible converter modules, that reside on the same card, or any other VBT or VBDT Card tied into the system.

Compatible modules on any board are allowed to be tied between, or to, each other for loopback, wraparound testing and real time systems test.

The **ARS T-Bus[™]** facilities **Real-Time on-line** (*live*) and off-line testing, and program controlled automatic testing down to the component converter level.

Because the ARS T-Bus[™] allows the program to run "live" (real-time testing) or, selectively disconnect the actual field wired signal lines in route to each converter;

Automatic System Debug, can easily discern converter verses field wiring or sensor faults in the overall system, and evaluate the differences between loaded and unloaded converter performance.



Multiple Inter-Board Test Paths

The on-board **ARS T-Bus**TM may be user strapped for routing to any one of *two different and distinct inter-card test buses* that are daisy chained between boards via the **P2** expansion port *or the Front Panel* (T-BusTM) connector ports.

The use of two-*different inter-card test buses* allows the user to run *separate high voltage synchro, and low voltage synchro buses within the same system*. Furthermore, the two different *Inter-card buses can be staggered for expansion into a third* RVDT/LVDT test bus, *or* even a *fourth or fifth multichannel* A-D/D-A *test bus* etc.

Test Bus Integrity

Unlike other test methods that employ stepping up/down signal voltages for testing, or fixed step changes to verify limited functionality; the "ARS T-BusTM" routes the real (true voltage) signal lines as they enter the circuit card, this permits 100% true testing ability.

The use of real (true-voltage) signal lines, and a **true isolated test bus** for Loop-Back allows the program to **discern positively**, (with confidence) whether a failure is an on-board or field fault.

(Request full VBT/VBDT Data Sheets, Block Diagrams on following page.)

Safe-Lock[™] Control Logic

The **ARS T-BusTM** uses a unique register based control structure employing the use of CCC's "Safe-Lock TM control logic". A single Safe-LockTM Command Register is provided to request the desired routing of signals, and a Safe-LockTM Status Register is provided to confirm if and when the commanded routing is set.

All the **ARS T-Bus**TM; interlock, non-contention, bus-busy, time-out and signal compatibility checking logic, is transparent to the user, and **automatically** controlled with the on-board Safe-LockTM control logic.

Application Testing

Loop-back testing is primarily used immediately following power-ups, to step the converters through a user programmed exercise.

Real-time testing is performed by monitoring the signals and converters while in operation, and/or comparing the actual performance with another channel in the system (running concurrent to the live channel being tested), or a simulation of the expected.

The use of 100% transformer-isolated converters and a physically isolated test bus switching matrix; allows users to integrate Automatic Test Systems with guaranteed confidence and 100% assured performance.



J2: insert A16 = Short,

insert A24 = Std.

F	Base Address Select, J1 Jumpers = A0 - A23 Address Bits, in = 0, out = 1																
	A	4		5			А			5			0	0			
		1	0	0		0		1			0					0000	0
23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	A7-A0	Base

P2	PIN TERMINATIONS: VBR,VBW,VBD Series Units Front Panel Connectors P3 & P4 Disregard unused channels if not in your part number. © CCC 1997, 1999										P2									
P2 Pins	P3 Pins	VBD	SERIES High Density	VBW/VBR * = QM Oj	VBW/VBR Units * = QM Option			VBD	SERIES High Density	VBR/VBW * = QM O	VBR/VBW Units * = QM Option									
C6	9	RH	Deferment	-8 units	RH	rved	9	RH	Deferment	-8 units	RH	C18								
A6	28	RL	Keterence	RH/RL 0	RL	esei	28	RL	Reference	RH/RL 2	RL	A18								
A5	10	S1		If used as	S1	s R	10	S1		If used as	S1	A17								
A2	13	S2	Signals Channel 0	Multispeed:,	S2	ght	13	S2	Signals Channel	Multispeed:,	S2	A14								
C5	29	S3		chan.'s 0, 4 are Fine	S3	I Ri	29	S3	2	chan.'s 2, 6 are Fine	S3	C17								
C2	32	S4		Pair with	S4	Al	32	S4		Pair with	S4	C14								
C4	30	S1		chan.'s 2,5	*В-	999,	30	S1		chan.'s 3,7	*B-	C16								
C3	31	S2	Signals Channel	= coarse & Read or	*B+	C 16	31	S2	Signals Channel	= coarse & Read or Write In	*B+	C15								
A4	11	S3	4	Write In	*A-	CC	11	S3	6		*A-	A16								
A3	12	S4		Succession	*A+	ht (12	S4		Succession	*A+	A15								
A1	15	ODT	Vel.0 or RL4	-8 units	*M+	vrig	15	ODT	Vel.2 or RL6	-8 units	*M+	A13								
C1	34	OP I.	Vel.4 or RH4	RH/RL 4	*M-	(do)	34	OP I.	Vel.6 or RH6	RH/RL 6	*M-	C13								
C12	1	RH	Reference	-8 units	RH	0 0	1	RH	Reference	-8 units	RH	C24								
A12	20	RL	Kelefence	RH/RL 1	RL) uc	20	RL		RH/RL 3	RL	A24								
A11	2	S1	Signals Channel	If used as	S1	atic	2	S1	Signals Channel 3	If used as	S1	A23								
A8	5	S2		Multispeed:,	S2	iod.	5	S2		Multispeed:, chan.'s 2, 6 are Fine, Pair with	S2	A20								
C11	21	S3	1	chan.'s 0, 4	S3	Coi	21	S3			S3	C23								
C8	24	S4		Pair with	S4	SU	24	S4			S4	C20								
C10	22	S1										chan.'s 2,5	*B-	rsio	22	S1		chan.'s 3,7	*B-	C22
C9	23	S2	Signals Channel	= coarse & Read or	*B+	пуе	23	S2	Signals Channel 7	= coarse & Read or Write In	*B+	C21								
A10	3	S3	5	Write In	*A-	Coi	3	S3			*A-	A22								
A9	4	S4		Succession	*A+	ter	4	S4		Succession	*A+	A21								
A7	7	OPT	Vel.1 or RL5	-8 units	*M+	ndu	7	ODT	Vel.3 or RL7	-8 units	*M+	A19								
C7	26	OP I.	Vel.5 or RH5	RH/RL 5	*M-	Con	26	OP I.	Vel.7 or RH7	RH/RL 7	*M-	C19								
	18	+12V	If ext. supplies	-12 units are	e +/- or Ext		18	+12V	If ext. supplies	-12 units ar	e +/- or Ext.									
	36,37	GND	Power Ground	Otherwise +	-/-15		36,37	GND	Power Ground	Otherwise +	-/-15									
	19	-12V	If ext. supplies	VDC Ex	t.		19	-12V	If ext. supplies	VDC Ex	t.									
P2	6,25,1 I COM	4, & 33 DC IMON	DC	Common			6,25,14, & 33 DC COMMON		DC Common			P2								
			P3 & P4 Conne P3 & P4 Conne	ector AMP #7 ector AMP #7	45784- 45784-	4, Mate 4, Mate	s: TRW s: TRW	V/CINCI V/CINCI	H # DC-37P Inclu H # DC-37P Inclu	ded ded										



ADDRESSING

The physical module address is decoded by setting Address Select Jumpers for the desired AM code (address modifier) and base address (board select). Jumper plug installed equals logic "0".

ADDRESSING RANGE

CCC VME Modules are configured for the A24 standard addressing over a 16M byte range, two shunt jumpers are provided to permit A16 short addressing over a 64K byte range.

A24 MODE:

Uses address lines A01-A023. Jumper (J2) is inserted in the A24 position and jumper A16 (J3) is removed to allow standard addressing over a full 16M byte range.

Client may use the following Am codes (address modifiers):

"3D" Standard supervisory Data Access or,

"39" Standard Non-Privileged Data Access

A16 MODE:

Uses address lines A01-A015. Jumper (J2) is inserted in the A16 position and jumper A16 (J3) is installed to allow short addressing over a 64K byte range. Client may use the following AM codes:

"2D" short supervisory I/O Access or,

"29" short Non-Privileged I/O Access.

The base address may be set up via reliable shunt plugs anywhere on the 256 byte boundaries.

NOTES:

1) **READ BACK:** If channel zero is a primarily write converter function (ie: Digital to Synchro); then "00" in Hex is the address to Write the New Command Word, and "08" in Hex is the address to "READ-BACK' the Command Word for verification.

2) **READ STATUS:** This is a separate status register used for each module for fault and VME I/O Card configuration information.

On **High Density "VBD"** modules one status register is used for every two converters; they are paired per status register as channels 0 & 4, 1 & 5, 2 & 6, 3 & 7. All status bits apply equally to each channel with individual Fault/Bite Status bits for each respective channel.

3) **DTACK:** The CCC DTACK response is less then 9 VME Bus clock cycles for standard units, less then 14 for channels 4-7.

4) All CCC VME Bus cards are register based A24:D16 slave devices. All converters used are independent (not multiplexed) continuously tracking signal input converters, and independent continuously updated signal output converters.

These independent channels can be addressed and either written to, or read from, without any special timing considerations, specialized timing algorithms, or interrupts. The user simply addresses the channel, and reads or writes the data.

VME BUS I/O Cards ADDRESSING, STATUS WORD & CONTROL DETAILS

STATUS WORD & CONTROL WORD DETAILS

Status Word, Lower Byte (Higher Byte Not Used)

	ST	PF	F1	F2	F3	MP	W	R
Bits	D7	D6	D5	D4	D3	D2	D1	D0

Status Word (Read Functions):

1 status word per channel up to 4 channel units,

1 status word per every 2 channels on VBD units.

Bit D0: 0 = Read Channel:

This channel is configured for a Read Command. ex: Synchro to Digital or A to D.

Bit D1: 0 = Write Channel:

This channel is configured for a write command. ex: Digital to Synchro or D to A

*If both bits D0 and D1 are logic 1, this indicates no active module.

*If both bits D0 and D1 are logic 0, = configuration - Jumper error.

Bit D2:0=Multi-Pair:

This channel is paired with adjacent channel for a multispeed or Multiturn operation.

Channels 0 and 1, (4 and 5 Hi-Den)= Multi-pair #0,1

Channels 2 and 3, (6 and 7 Hi-Den)= Multi-pair #2,3 The paired channels should be read in succession. Not used on boards with multispeed converters.

Bit D3 : 1 = Converter Busy, (F3 Fault) not required to be polled, all cards insure valid data is always read by the bus.

Bit D4: ¹Converter Fault Channels 0,1,2, and 3

Bit D5: ¹Converter Fault Channels 4,5,6, and 7 (VBD units)

¹Loss of Reference, Loss of Signal, overspeed/accel. & conv. fault. If converter is given a large simulated step input stays until settled.

Bit D6: 0 = Power Fail, loss of +/-15 or +/-12VDC supplies.

Bit D7 : 1 = In Self Test Mode, all input converters should be reading 30° test angle +/-.15°. (-WS models only, else ignore).

Control Word (Write Self Test): (-WS Models Only) Control words compliment the status word address locations. Activating or deactivating the self-test mode by setting Bit D7 high = 1 in any of these locations will put the card into (or out of) the self test mode.

Bit D7 : 1 = Force into Self Test Mode, all input converters will internally disconnect their input signals and instead switch to read an analog simulated 30° test angle for a confirmation test. When activated look at the converter fault bits indicating when ready to read, if not settled (unfaulted) within 2 seconds = failed. Proceed by comparing the data read on each channel to 30° +/- .15°. When done set to 0 to activate the run mode, again check fault bits in the status word to make sure the converters are settled.

Bit D7: 1 = Force into Run Mode, normal operation.



в4

a b

ex.

(CH1) (CH2)

в4

a b

VBM

SELECT STYLE CARD

VBW = OUTPUT CARD VBR = INPUT CARD VBM = BOTH VBT = INCLUDES LOOP-BACK TEST BUS

VBD = HIGH DENSITY CARD **VBDT** = HD CARD W/LOOP-BACK TEST BUS -WS models include forced angle self-test

к4

a b

(CH4)

-X

options

SELECT ONE CONVERTER FOR EACH CHANNEL OR INSERT A #0 (EMPTY SPOT).

к4

a b

(CH3)

NOTES: 1) VBT CARDS ONLY USE 3 CHANNELS, VBDT CARDS USE ONLY 6 CHANNELS. 2) VBD CARDS SELECT CONVERTER STYLE FOR EACH PAIR OF "INPUT" CONVERTERS.

a) SELECT CONVERTER RESOLUTION: b) SELECT SIGNALS (INSERT CODE #):

SYNCHRO TO DIGITAL	REFERENCE	SIGNALS	FREQUENCY	CODE
$16 = \mathbf{A}, 14 = \mathbf{B}, 12 = \mathbf{C}, 10 = \mathbf{D}$	26VAC	11.8VL-L	400Hz.	1
RESOLVER TO DIGITAL	26VAC	11.8VL-L	2.6KHz.	2
$16 = \mathbf{E}, 14 = \mathbf{F}, 12 = \mathbf{G}, 10 = \mathbf{H}$	26VAC	26VL-L	400Hz.	3
DIGITAL TO SYNCHRO (DSL)	115VAC	90VL-L	400Hz.	4
$16 = \mathbf{J}, 14 = \mathbf{K}, 12 = \mathbf{M}, 10 = \mathbf{N}$	115VAC	90VL-L	60Hz.	5
DIGITAL TO SYNCHRO (DSP)	*115VAC	7V.L-L	400Hz.	6
14 BITS = \mathbf{P} , 16 Bits = Q	*115VAC	7V.L-L	60Hz.	7
DIGITAL TO RESOLVER	*26VAC	7V.L-L	400Hz.	8
$16 = \mathbf{R}, 14 = \mathbf{S}, 12 = \mathbf{T}, 10 = \mathbf{U}$				

*These converters typically used to drive power amplifiers 6 V.L-L with +/- 12VDC Bus Power.

ALL OTHER CONVERTERS REQUEST EXTENDED SELECTION GUIDE

OPTIONS

- 3 FOR EXT'D. OPERATING TEMP. -40 to 75 degrees C convection/air cooled
- 3C FOR EXT'D. OPERATING TEMP. -40 to 75 degrees C conduction cooled
- V FOR VELOCITY OUTPUTS
- 12 FOR $\pm 12V$ INSTEAD OF $\pm 15V$ SUPPLIES.
- M FOR MULTISPEED UNITS.
- P2 FOR P2 I/O VERSES FRONT PANEL, OR B FOR BOTH
- 883 FOR HIGH RELIABILITY 38510/883 LEVEL B PARTS/PROCESSING
- -8 FOR INDEPENDENCE REFERENCES/NOT PAIRED ON VBD MODELS
- Q FOR QUADRATURE INCREMENTAL ENCODER OUTPUTS, add Z for marker.
- -WS FOR UNITS WITH ON-BOARD SELF-TEST (Input Channels)
- -RS FOR WITH REFERENCE SUPPLY, Up to 5VA
- -SR FOR WITH MULTIPLE REFERENCE SUPPLIES
 - Note: multiple reference supplies avail. 4 channel units can have up to 1 reference supply/channel, 8 Channel VBD type units can have up to 4 paired reference supply outputs/card, 1VA ea.
 - 8 Channel V BD type units can have up to 4 paired reference supply outputs/card,
- -F FOR WITH EXTERNAL FREEZE INPUT CONTROL LINES.

QUALITY NOTE: CCC quality assurance program conforms to MIL-I-45208. All CCC products manufactured in U.S.A..

All Units Shipped with Printed Test Data, and Certificate of Compliance

LVDT/RVDT I/O, SCDX Differentials, SCT's, Dynamic Rotators, and 100's of other converter options avail.

ORPORATION

Phone (631)261-3300 Fax 261-3308

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VME COMPATIBLE ISOLATED SYNCHRO I/O CARD PRODUCT PROFILE

Bus Compliance: Commercial/industrial grade units comply with VME Rev. C.1, IEC 821 and IEEE 1014-1987. A24: D16 VME Bus slave-isolated, 6UH. Single slot width (unless otherwise specified for double slot).

- **Isolation:** 100% Internal Transformer/Isolated I/O, 500 VDC min. channel to channel and channel to bus. All signal and reference inputs feature complete isolation, to eliminate concerns of ground loops, entry of field electrical noise EMI/RFI, ground line interference, and differing potentials. This completely isolates all of the field I/O from rather fragile/sensitive computer bus, to preserve and assure optimum system integrity. (Models with X in the P/N).
 - **Safety!** All modules are encapsulated in an inert polymer that is self-extinguishing, flame retardant to U.L. 94VO, and will not feed or combust. Printed Circuit card material is flame retardant FR4, assemblies are conformal-coated for moisture resistance. Transformers are manufactured to MIL-T-27 and capable of withstanding high-pot to 500VDC. Case is flame resistant glass filled Diallyl Phthalate per MIL-M-14. Because all the high voltage circuitry is encapsulated within the self-extinguishing and flame retardant potting material; added protection is provided with respect to the potential for component failure, shock and vibration, and are suitable for the most severe industrial and military applications.
- **Diagnostics:** Via on board status register, includes channel present and channel read/write card config. loss of ±12V supplies, input converters provide reference/signal loss detect, "BIT" Built-In-Test/fault status bit per input channel detecting converter tracking mode, under/over acceleration and overspeed conditions. (Input channels).
 - **Power:** Bus powered off the P1 connector, no external supplies required. Jumper provision allows the use of external +12V supplies via P2 and/or front panel connectors.
 - **I/O:** All I/O provided through P2 and/or front panel connectors, both are standard, -FP units are front panel only, -P2 are P2 only.

Environmental: Temperature:

Standard Units: Operating: 0 to 70°, 0 to 60°C, installed, Extended Units: -3 Suffix: operating -40°C to +85°C, -40°C to +75°C installed, Storage: -55° to +125°C

Humidity: 0 to 95% non-condensing, conformal coating available.

Vibration: 3.5 mm. 5-9Hz.: 1.0 G 9-150HZ.

Shock: 15 g's for 11 msec.

Note: Environmental specifications shown are as minimums, test and conformance to greater extremes may be provided, in addition: conformal coating, extended burn-in, thermal conductive layer heat sinking with wedge blocks, extended military temperature range componentry, 883B/38510, and source inspection may be provided on request.

- **Quality:** CCC quality assurance program conforms to MIL-I-45208.
- *Warranty:* 1 year from Date of Shipment, All units shipped with printed test data.
- **Includes:** Board Assemblies are completely preassembled and tested as whole, provided with printed test data, test data file, COTS data pack documentation, certificate of compliance, and mating connectors. Source inspection available on request.